



Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

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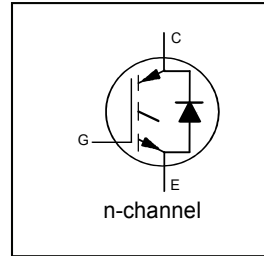
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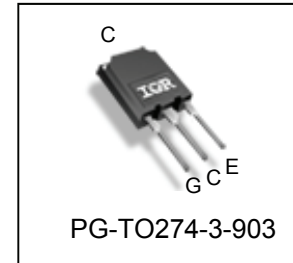


**INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE**
**Features**

- Low  $V_{CE(on)}$  Trench IGBT Technology
- Low Switching Losses
- 6 $\mu$ s SCSOA
- Square RBSOA
- 100% of the parts tested for  $I_{LM}$  ①
- Positive  $V_{CE(on)}$  Temperature Coefficient
- Soft Recovery Co-pak Diode
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



$V_{CES} = 600V$   
 $I_C = 160A, T_C = 100^\circ C$   
 $t_{sc} \geq 6\mu s, T_{J(MAX)} = 175^\circ C$   
 $V_{CE(on) typ.} = 1.70V$



G	C	E
Gate	Collector	Emitter

**Benefits**

- High Efficiency in a Wide Range of Applications
- Suitable for Applications in the Low to Mid-Range Frequencies
- Rugged Transient Performance for Increased Reliability
- Excellent Current Sharing in Parallel Operation
- Low EMI

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRGPS4070D0	PG-TO274-3-903	Tube	25	AUIRGPS4070D0

**Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature ( $T_A$ ) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	240⑤	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	160	
$I_{NOMINAL}$	Nominal Current	120	
$I_{CM}$	Pulse Collector Current, $V_{GE} = 15V$	360	
$I_{LM}$	Clamped Inductive Load Current, $V_{GE} = 20V$ ①	480	
$I_{F NOMINAL}$	Diode Nominal Current ②	120⑤	
$I_{FM}$	Diode Maximum Forward Current ②	480	
$V_{GE}$	Continuous Gate-to-Emitter Voltage	$\pm 20$	V
	Transient Gate-to-Emitter Voltage	$\pm 30$	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	750	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	375	
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	

**Thermal Resistance**

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$ (IGBT)	Thermal Resistance Junction-to-Case (each IGBT) ④	—	0.20	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance Junction-to-Case (each Diode) ④	—	0.45	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink (flat, greased surface)	0.24	—	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (typical socket mount)	—	40	

\* Qualification standards can be found at [www.infineon.com](http://www.infineon.com)



**Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)**

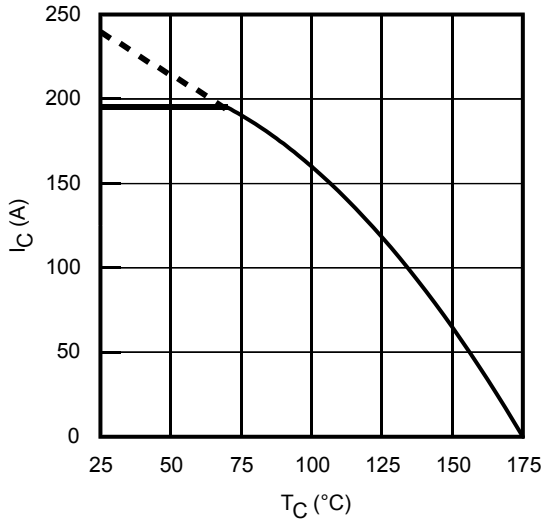
	Parameter	Min.	Typ.	Max.	Units	Conditions
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage	600	—	—	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 500μA ③
ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub>	Temperature Coeff. of Breakdown Voltage	—	0.74	—	V/°C	V <sub>GE</sub> = 0V, I <sub>C</sub> = 5mA (25°C-175°C)
V <sub>CE(on)</sub>	Collector-to-Emitter Saturation Voltage	—	1.7	2.0	V	I <sub>C</sub> = 120A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 25°C
		—	2.0	—		I <sub>C</sub> = 120A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 150°C
		—	2.1	—		I <sub>C</sub> = 120A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 175°C
V <sub>GE(th)</sub>	Gate Threshold Voltage	4.0	—	6.5	V	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 5.6mA
ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>	Threshold Voltage temp. coefficient	—	-16	—	mV/°C	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 5.6mA (25°C-175°C)
g <sub>fe</sub>	Forward Transconductance	—	87	—	S	V <sub>CE</sub> = 50V, I <sub>C</sub> = 120A
I <sub>CES</sub>	Collector-to-Emitter Leakage Current	—	1.0	200	μA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V
		—	2.0	—	mA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 600V, T <sub>J</sub> = 175°C
V <sub>FM</sub>	Diode Forward Voltage Drop	—	1.8	2.1	V	I <sub>F</sub> = 120A
		—	1.9	—		I <sub>F</sub> = 120A, T <sub>J</sub> = 175°C
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	—	—	±100	nA	V <sub>GE</sub> = ±20V

**Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)**

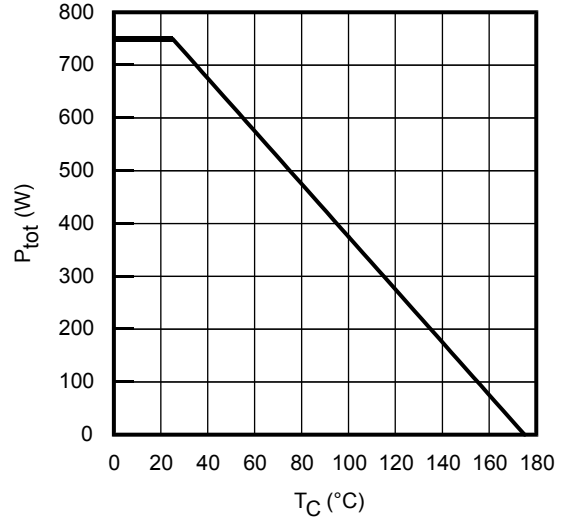
	Parameter	Min.	Typ.	Max.	Units	Conditions	
Q <sub>g</sub>	Total Gate Charge (turn-on)	—	250	375	nC	I <sub>C</sub> = 120A V <sub>GE</sub> = 15V V <sub>CC</sub> = 400V	
Q <sub>ge</sub>	Gate-to-Emitter Charge (turn-on)	—	65	98			
Q <sub>gc</sub>	Gate-to-Collector Charge (turn-on)	—	100	150			
E <sub>on</sub>	Turn-On Switching Loss	—	5.7	6.7	mJ	I <sub>C</sub> = 120A, V <sub>CC</sub> = 400V, V <sub>GE</sub> = 15V R <sub>G</sub> = 4.7Ω, L = 87μH, T <sub>J</sub> = 25°C Energy losses include tail & diode reverse recovery	
E <sub>off</sub>	Turn-Off Switching Loss	—	4.2	5.2			
E <sub>total</sub>	Total Switching Loss	—	9.9	11.9			
t <sub>d(on)</sub>	Turn-On delay time	—	40	60	ns		
t <sub>r</sub>	Rise time	—	125	155			
t <sub>d(off)</sub>	Turn-Off delay time	—	140	170			
t <sub>f</sub>	Fall time	—	120	170			
E <sub>on</sub>	Turn-On Switching Loss	—	6.4	—	mJ		I <sub>C</sub> = 120A, V <sub>CC</sub> = 400V, V <sub>GE</sub> = 15V R <sub>G</sub> = 4.7Ω, L = 87μH, T <sub>J</sub> = 175°C Energy losses include tail & diode reverse recovery
E <sub>off</sub>	Turn-Off Switching Loss	—	4.7	—			
E <sub>total</sub>	Total Switching Loss	—	11.1	—			
t <sub>d(on)</sub>	Turn-On delay time	—	40	—	ns		
t <sub>r</sub>	Rise time	—	110	—			
t <sub>d(off)</sub>	Turn-Off delay time	—	160	—			
t <sub>f</sub>	Fall time	—	125	—			
C <sub>ies</sub>	Input Capacitance	—	7600	—	pF	V <sub>GE</sub> = 0V V <sub>CC</sub> = 30V f = 1.0Mhz	
C <sub>oes</sub>	Output Capacitance	—	510	—			
C <sub>res</sub>	Reverse Transfer Capacitance	—	230	—			
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				T <sub>J</sub> = 175°C, I <sub>C</sub> = 480A V <sub>CC</sub> = 480V, V <sub>p</sub> ≤ 600V R <sub>G</sub> = 4.7Ω, V <sub>GE</sub> = +20V to 0V	
SCSOA	Short Circuit Safe Operating Area	6	—	—	μs	V <sub>CC</sub> = 400V, V <sub>p</sub> ≤ 600V R <sub>G</sub> = 5.0Ω, V <sub>GE</sub> = +15V to 0V	
E <sub>rec</sub>	Reverse Recovery Energy of the Diode	—	1740	—	μJ	T <sub>J</sub> = 175°C	
t <sub>rr</sub>	Diode Reverse Recovery Time	—	210	—	ns	V <sub>CC</sub> = 400V, I <sub>F</sub> = 120A	
I <sub>rr</sub>	Peak Reverse Recovery Current	—	45	—	A	V <sub>GE</sub> = 15V, R <sub>G</sub> = 4.7Ω, L = 87μH	

**Notes:**

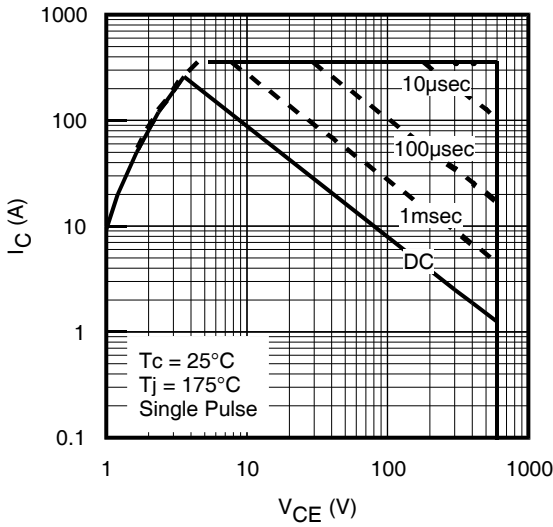
- ① V<sub>CC</sub> = 80% (V<sub>CES</sub>), V<sub>GE</sub> = 20V, L = 3.5μH, R<sub>G</sub> = 47 Ω tested in production ILM ≤ 400A.
- ② Pulse width limited by max. junction temperature.
- ③ Refer to AN-1086 for guidelines for measuring V<sub>(BR)CES</sub> safely.
- ④ R<sub>θ</sub> is measured at T<sub>J</sub> approximately 90°C.
- ⑤ Calculated continuous current based on maximum allowable junction temperature. Package IGBT current limit is 195A. Package diode current limit is 120A. Note that current limitations arising from heating of the device leads may occur.



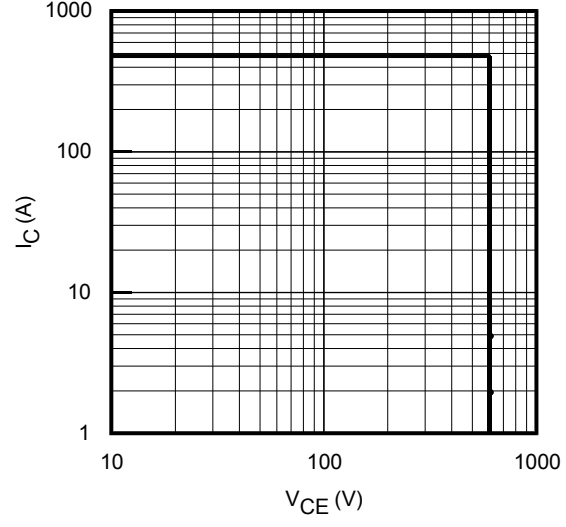
**Fig. 1 - Maximum DC Collector Current vs. Case Temperature**



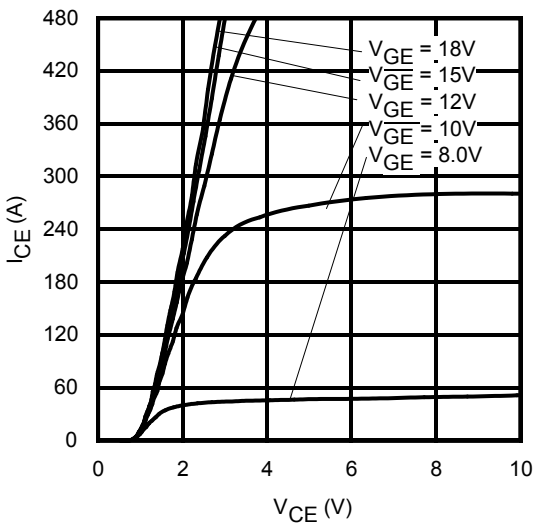
**Fig. 2 - Power Dissipation vs. Case Temperature**



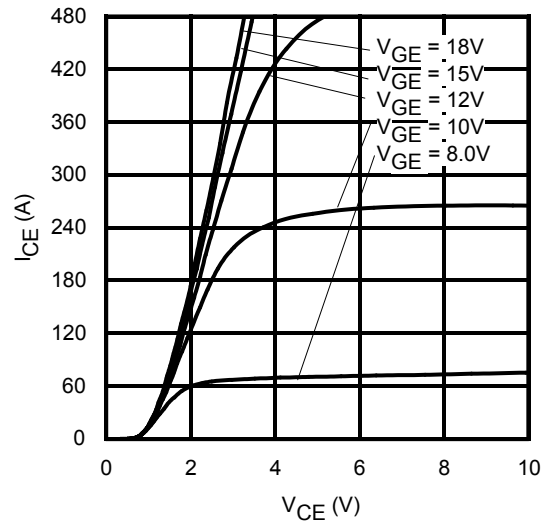
**Fig. 3 - Forward SOA**  
 $T_C = 25^\circ\text{C}$ ,  $T_J \leq 175^\circ\text{C}$ ;  $V_{GE} = 15\text{V}$



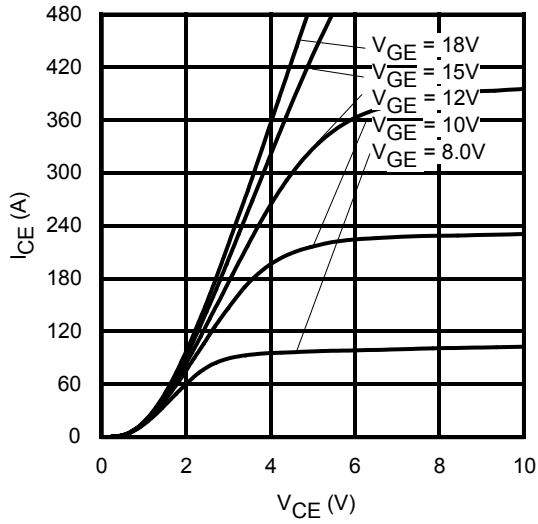
**Fig. 4 - Reverse Bias SOA**  
 $T_J = 175^\circ\text{C}$ ;  $V_{GE} = 20\text{V}$



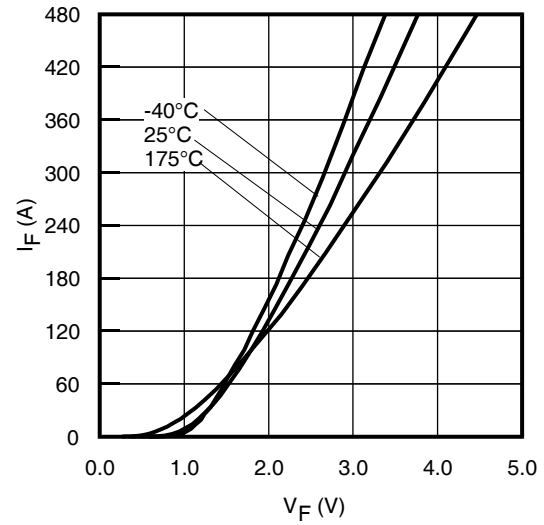
**Fig. 5 - Typ. IGBT Output Characteristics**  
 $T_J = -40^\circ\text{C}$ ;  $t_p = 20\mu\text{s}$



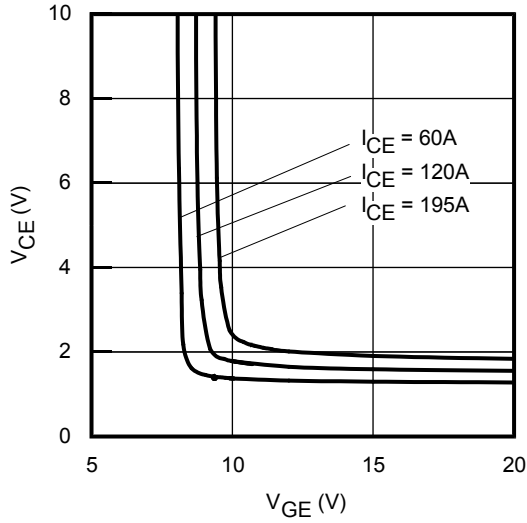
**Fig. 6 - Typ. IGBT Output Characteristics**  
 $T_J = 25^\circ\text{C}$ ;  $t_p = 20\mu\text{s}$



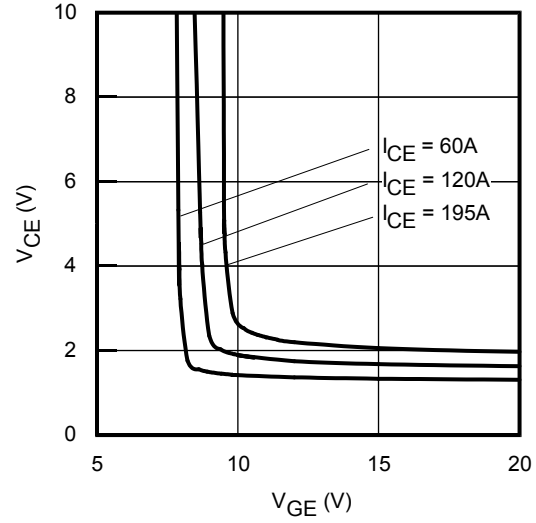
**Fig. 7 - Typ. IGBT Output Characteristics**  
 $T_J = 175^\circ\text{C}$ ;  $t_p = 20\mu\text{s}$



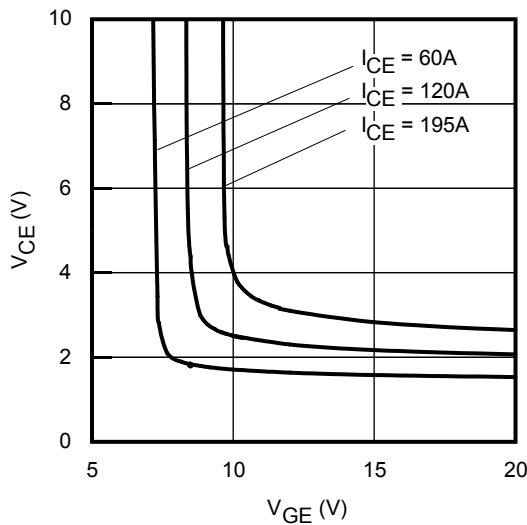
**Fig. 8 - Typ. Diode Forward Characteristics**  
 $t_p = 20\mu\text{s}$



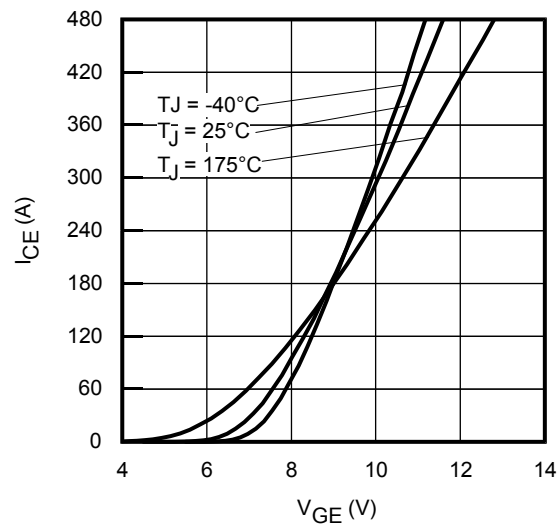
**Fig. 9 - Typical  $V_{CE}$  vs.  $V_{GE}$**   
 $T_J = -40^\circ\text{C}$



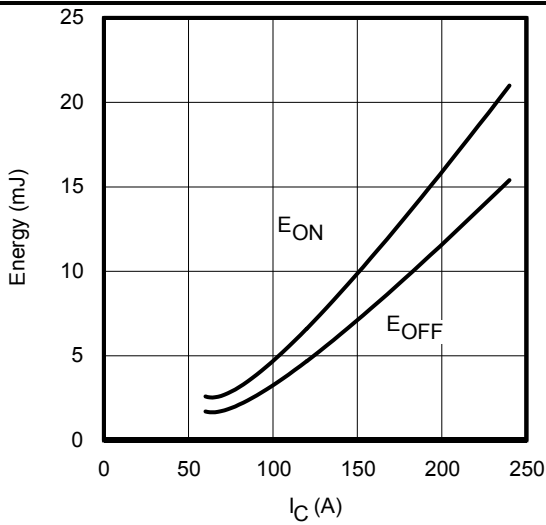
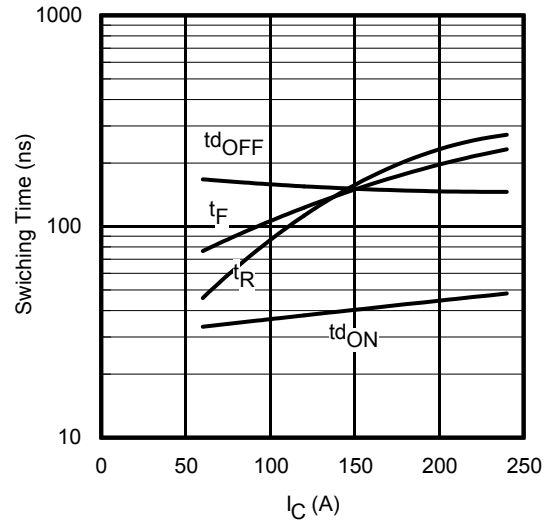
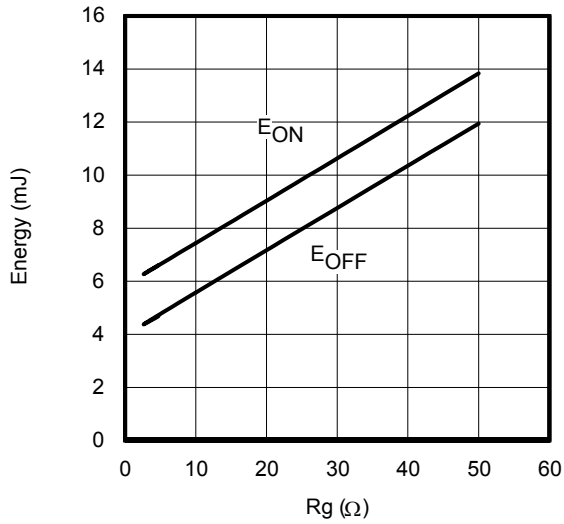
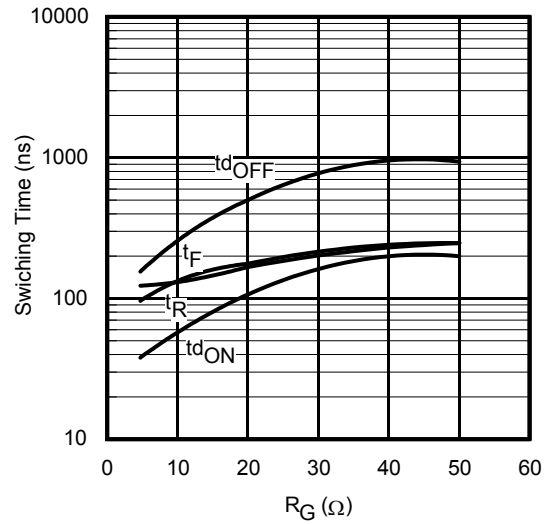
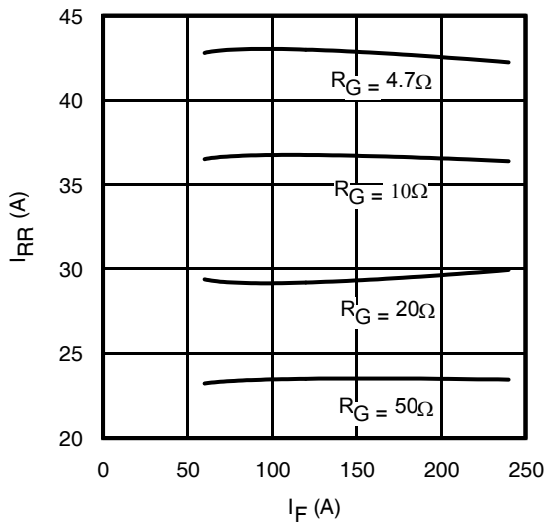
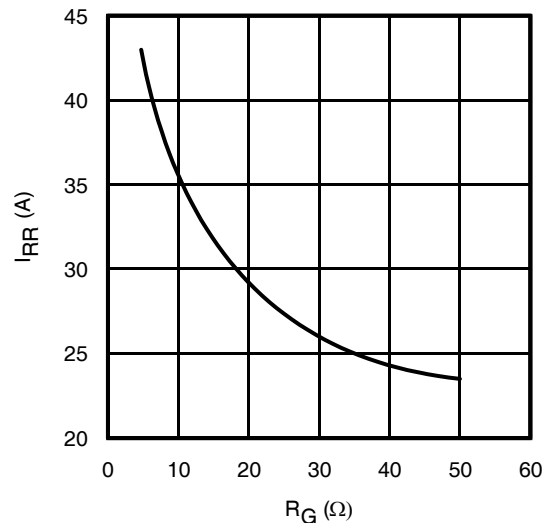
**Fig. 10 - Typical  $V_{CE}$  vs.  $V_{GE}$**   
 $T_J = 25^\circ\text{C}$

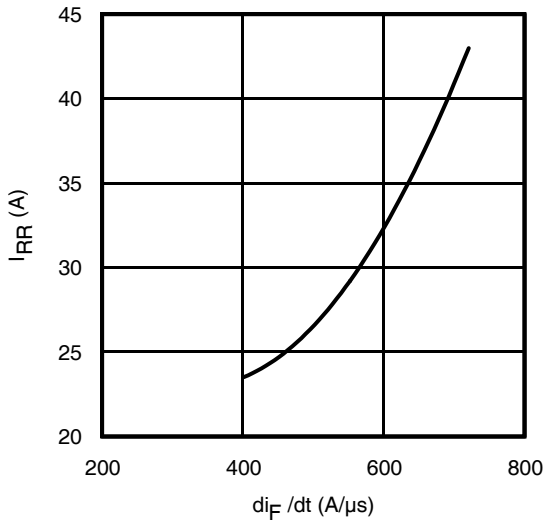


**Fig. 11 - Typical  $V_{CE}$  vs.  $V_{GE}$**   
 $T_J = 175^\circ\text{C}$

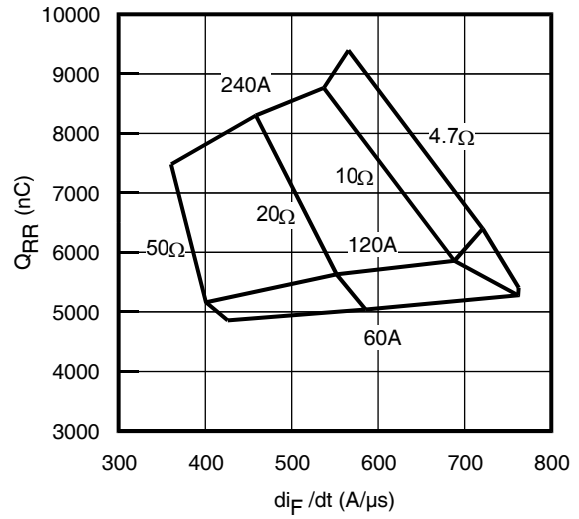


**Fig. 12 - Typ. Transfer Characteristics**  
 $V_{CE} = 50\text{V}$ ;  $t_p = 20\mu\text{s}$

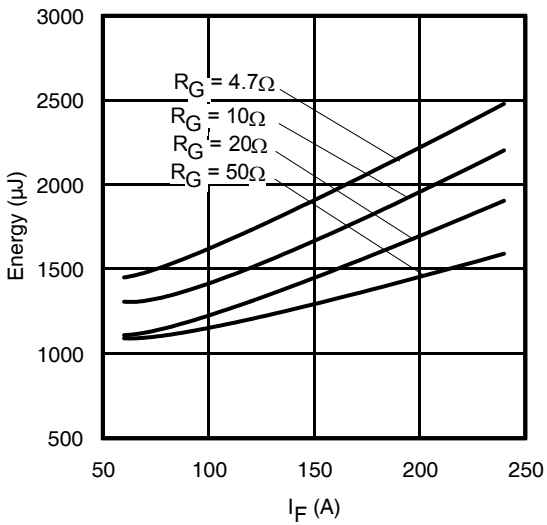

**Fig. 13 - Typ. Energy Loss vs.  $I_C$** 
 $T_J = 175^\circ\text{C}; L = 0.087\text{mH}; V_{CE} = 400\text{V}, R_G = 4.7\Omega; V_{GE} = 15\text{V}$ 

**Fig. 14 - Typ. Switching Loss vs.  $I_C$** 
 $T_J = 175^\circ\text{C}; L = 0.087\text{mH}; V_{CE} = 400\text{V}, R_G = 4.7\Omega; V_{GE} = 15\text{V}$ 

**Fig. 15 - Typ. Energy Loss vs.  $R_G$** 
 $T_J = 175^\circ\text{C}; L = 0.087\text{mH}; V_{CE} = 400\text{V}, I_{CE} = 120\text{A}; V_{GE} = 15\text{V}$ 

**Fig. 16 - Typ. Switching Time vs.  $R_G$** 
 $T_J = 175^\circ\text{C}; L = 0.087\text{mH}; V_{CE} = 400\text{V}, I_{CE} = 120\text{A}; V_{GE} = 15\text{V}$ 

**Fig. 17 - Typ. Diode  $I_{RR}$  vs.  $I_F$**   
 $T_J = 175^\circ\text{C}$ 

**Fig. 18 - Typ. Diode  $I_{RR}$  vs.  $R_G$**   
 $T_J = 175^\circ\text{C}$



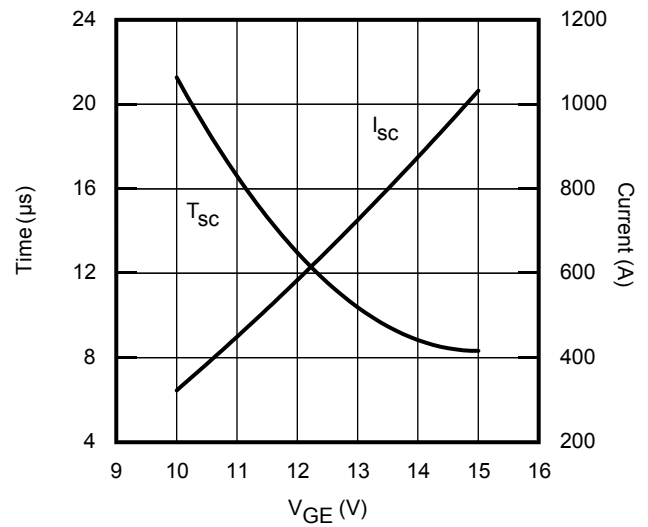
**Fig. 19** - Typ. Diode  $I_{RR}$  vs.  $di_F/dt$   
 $V_{CC} = 400V$ ;  $V_{GE} = 15V$ ;  $I_F = 120A$ ;  $T_J = 175^\circ C$



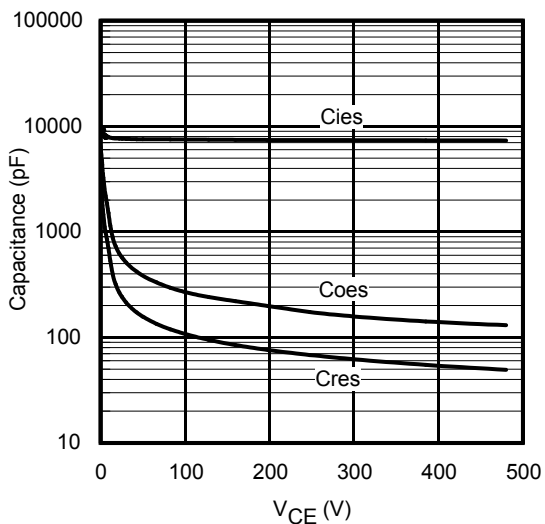
**Fig. 20** - Typ. Diode  $Q_{RR}$  vs.  $di_F/dt$   
 $V_{CC} = 400V$ ;  $V_{GE} = 15V$ ;  $T_J = 175^\circ C$



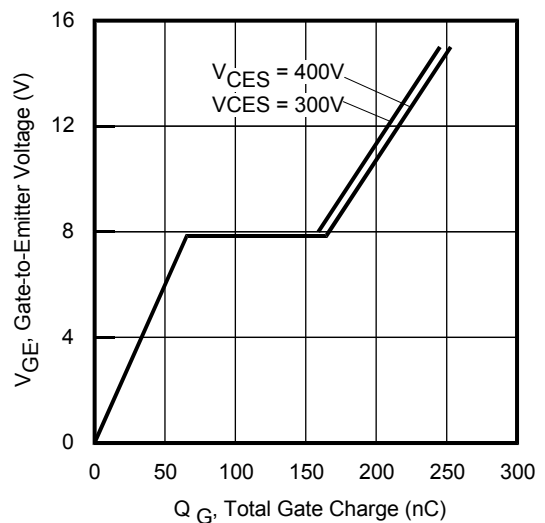
**Fig. 21** - Typ. Diode  $E_{RR}$  vs.  $I_F$   
 $T_J = 175^\circ C$



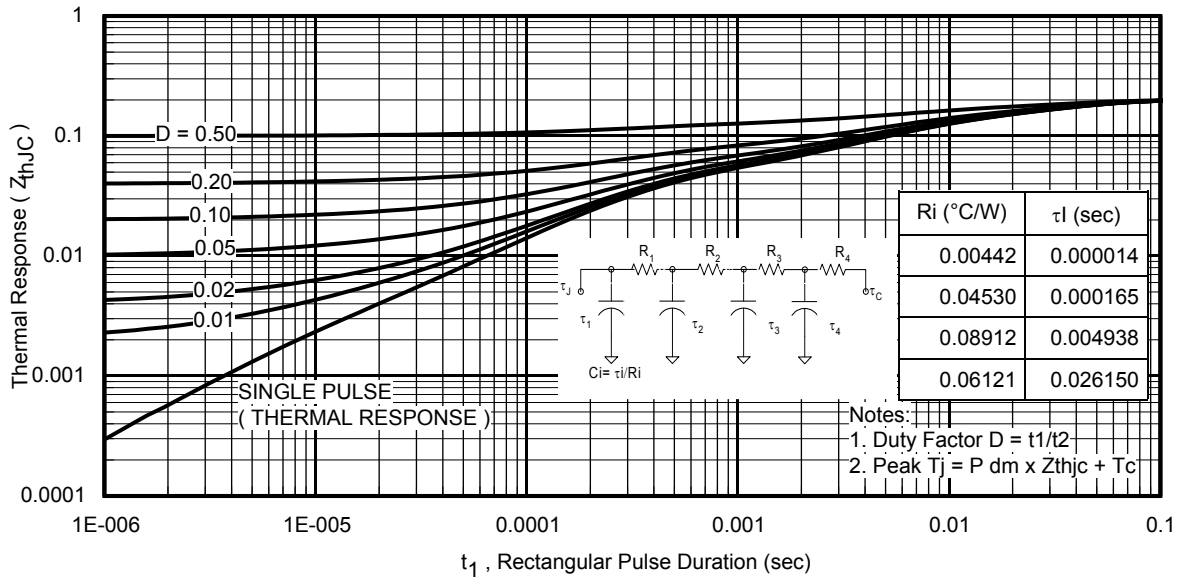
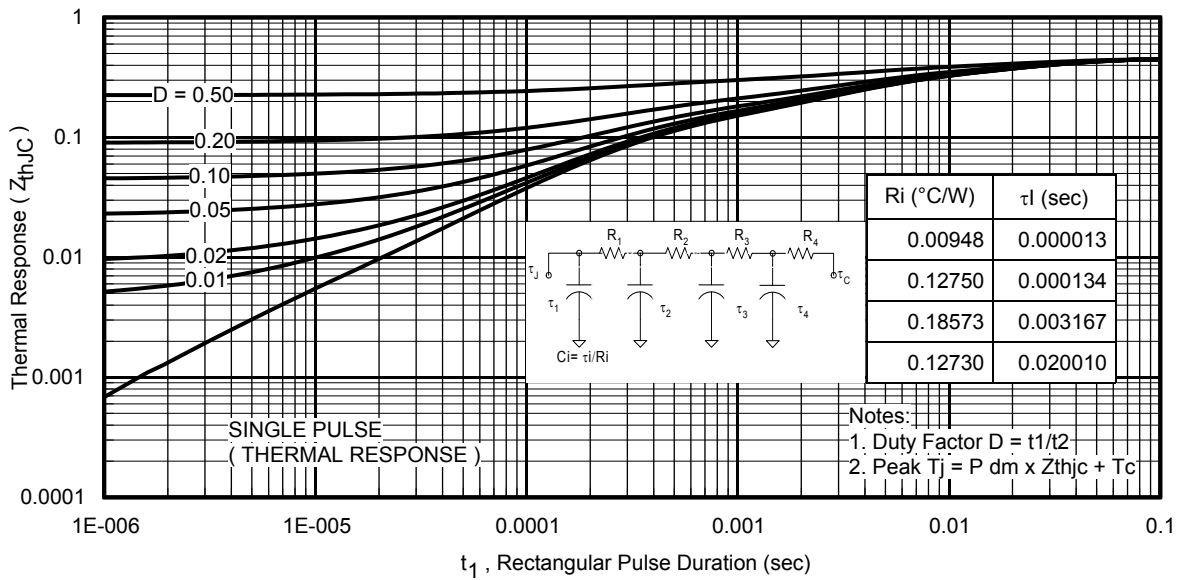
**Fig. 22** -  $V_{GE}$  vs. Short Circuit Time  
 $V_{CC} = 400V$ ;  $T_C = 25^\circ C$



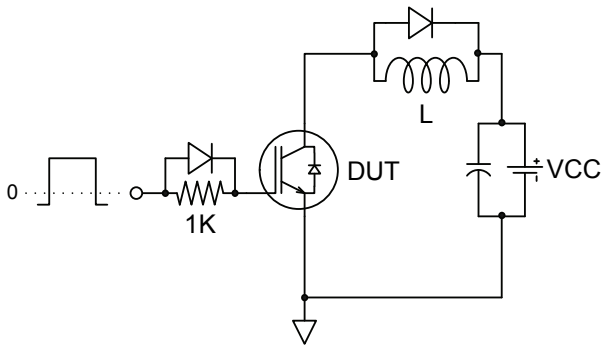
**Fig. 23** - Typ. Capacitance vs.  $V_{CE}$   
 $V_{GE} = 0V$ ;  $f = 1MHz$



**Fig. 24** - Typical Gate Charge vs.  $V_{GE}$   
 $I_{CE} = 120A$

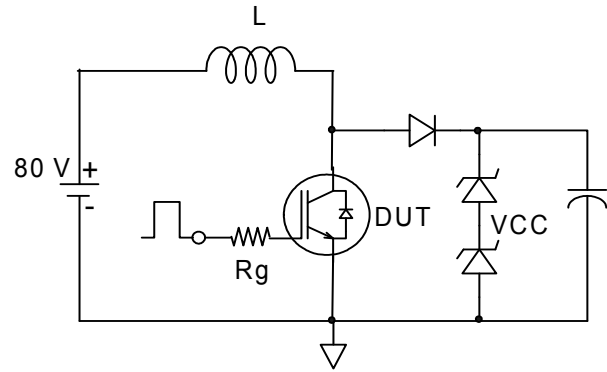

**Fig 25. Maximum Transient Thermal Impedance, Junction-to-Case (IGBT)**

**Fig 26. Maximum Transient Thermal Impedance, Junction-to-Case (DIODE)**





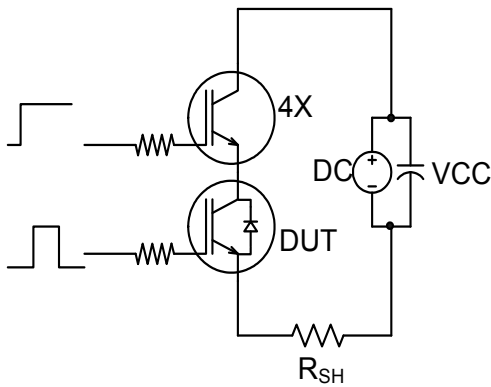
Gate Charge Circuit

**Fig.C.T.1** - Gate Charge Circuit (turn-off)

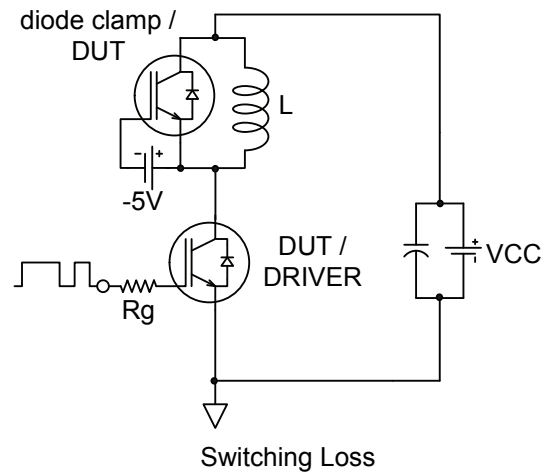


RBSOA Circuit

**Fig.C.T.2** - RBSOA Circuit

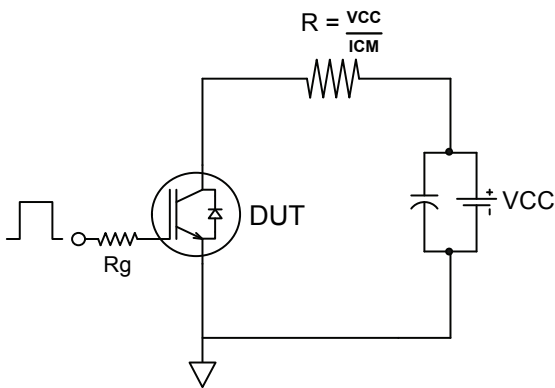


**Fig.C.T.3** - S.C. SOA Circuit

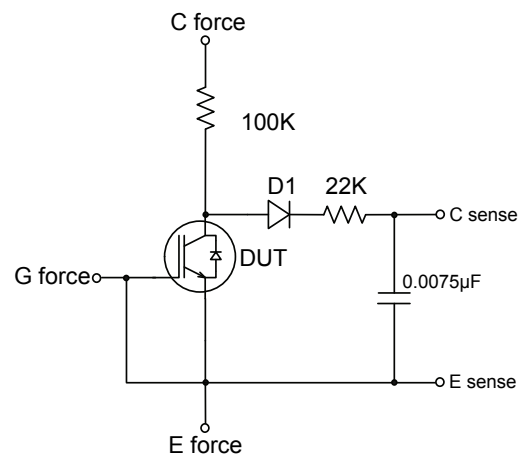


Switching Loss

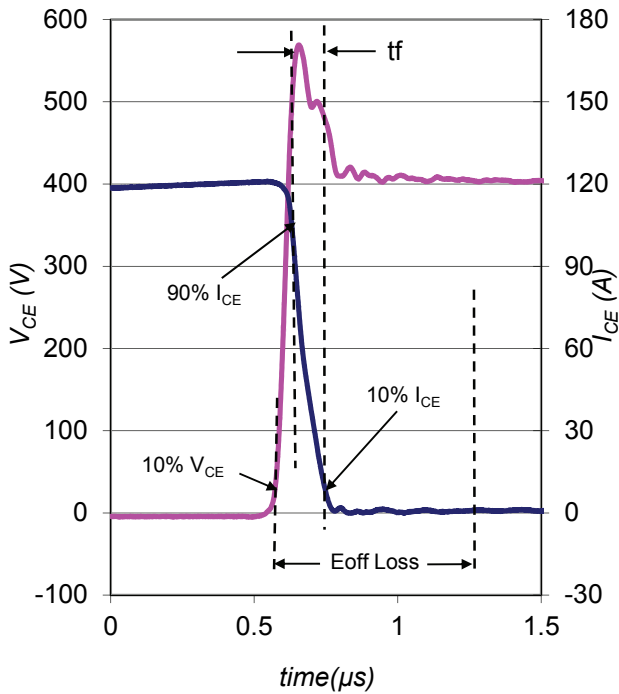
**Fig.C.T.4** - Switching Loss Circuit



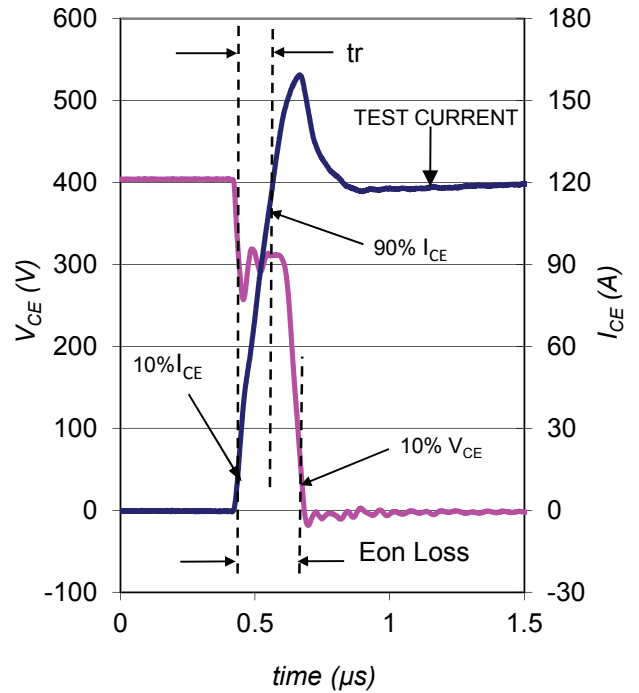
**Fig.C.T.5** - Resistive Load Circuit



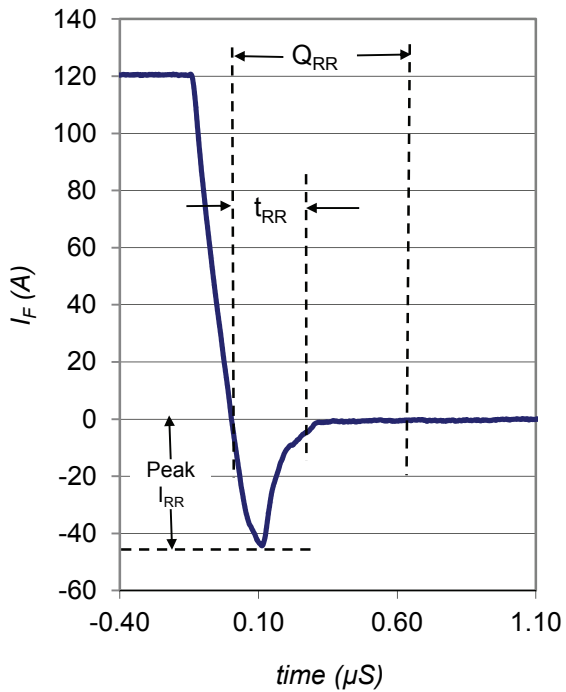
**Fig.C.T.6** - BVCEs Filter Circuit



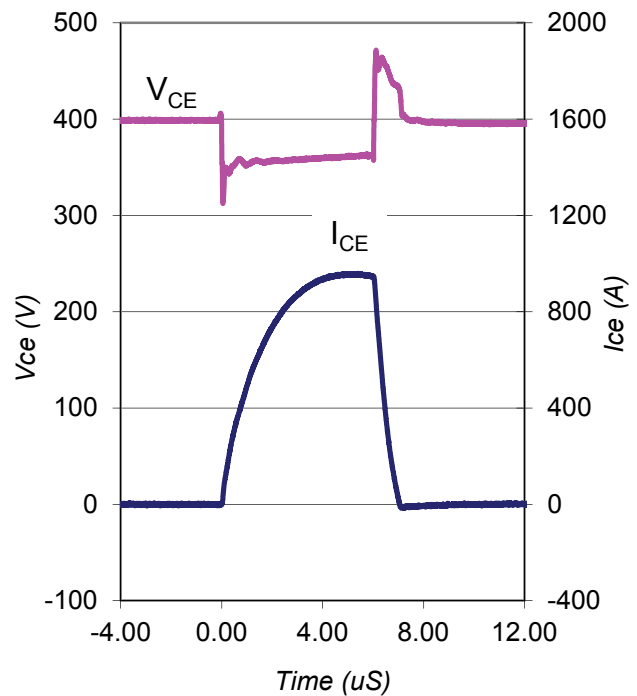
**Fig. WF1** - Typ. Turn-off Loss Waveform  
@  $T_J = 175^\circ\text{C}$  using Fig. CT.4



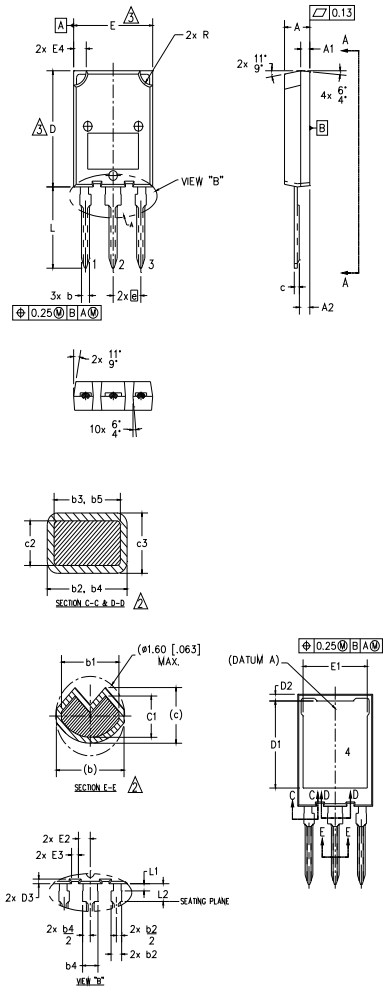
**Fig. WF2** - Typ. Turn-on Loss Waveform  
@  $T_J = 175^\circ\text{C}$  using Fig. CT.4



**Fig. WF3** - Typ. Diode Recovery Waveform  
@  $T_J = 175^\circ\text{C}$  using Fig. CT.4



**Fig. WF4** - Typ. S.C. Waveform  
@  $T_J = 25^\circ\text{C}$  using Fig. CT.3

**Case Outline and Dimensions-PG-TO274-3-903** (Dimensions are shown in millimeters (inches))

**NOTES:**

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
2. DIMENSIONS b1, b3, b5, c1 & c3 APPLY TO BASE METAL ONLY.
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER EXTREMES OF THE PLASTIC BODY.
- 4.- ALL DIMENSIONS SHOWN IN MILLIMETERS.
- 5.- CONTROLLING DIMENSION: MILLIMETER.
- 6.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-274AA

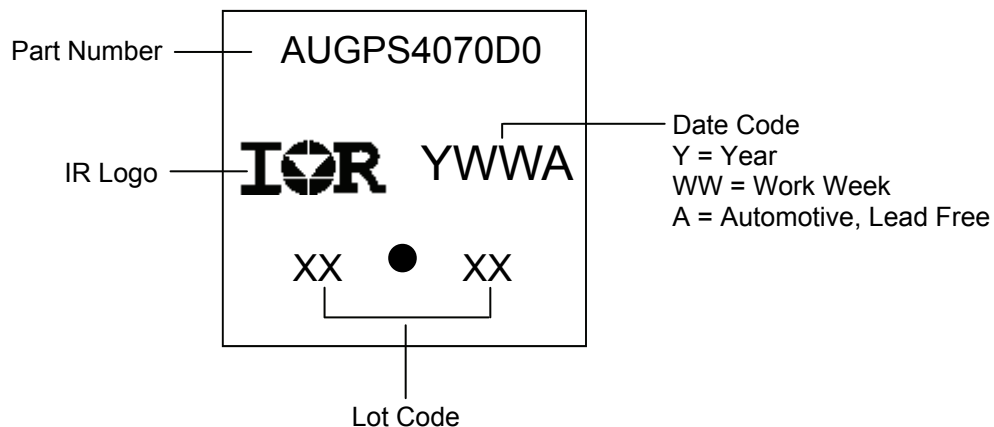
SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	4.50	5.50	.177	.217	
A1	1.45	2.15	.057	.085	
A2	1.65	2.35	.065	.093	
b	1.45	1.60	.054	.063	
b1	1.40	1.50	.055	.059	2
b2	2.00	2.40	.079	.094	
b3	1.95	2.35	.077	.093	2
b4	3.00	3.15	.118	.124	
b5	2.95	3.35	.116	.132	2
c	1.10	1.30	.043	.051	
c1	0.90	1.10	.035	.043	2
c2	0.65	0.85	.026	.033	
c3	0.50	0.70	.020	.028	2
D	19.80	20.80	.780	.819	3
D1	15.50	16.10	.610	.634	
D2	0.70	1.30	.028	.051	
D3	0.75	1.25	.030	.049	
E	15.10	16.10	.594	.634	3
E1	13.30	13.90	.524	.547	
E2	2.25	2.70	.089	.109	
E3	1.20	1.70	.047	.067	
E4	2.00	3.00	.079	.118	
e	5.45 BSC		.215 BSC		
L	13.80	14.80	.535	.583	
L1	1.00	1.60	.039	.063	
L2	3.85	4.25	.152	.167	
R	2.00	3.00	.079	.118	

**LEAD ASSIGNMENTS**
**MOSFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

**IGBT**

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

**PG-TO274-3-903 -Part Marking Information**


**Qualification Information**

<b>Qualification Level</b>		Automotive (per AEC-Q101)	
		This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
<b>Moisture Sensitivity Level</b>		PG-TO274-3-903	N/A
<b>ESD</b>	Human Body Model	Class H3B(+/- 8000) <sup>†</sup> AEC-Q101-001	
	Charged Device Model	Class C3 (+/- 2000) <sup>†</sup> AEC-Q101-005	
<b>RoHS Compliant</b>		Yes	

† Highest passing voltage.

**Revision History**

Date	Comments
08/31/2017	• Corrected typo error on part marking on page 10.
11/14/2017	• Corrected the reference of "SUPER-247" to "PG-STO247-3-1" to align with IFX nomenclature on pages 1,10,11.
07/19/2018	• Corrected the reference of "PG-STO247-3-1" to "PG-TO274-3-903" to align with IFX nomenclature on pages 1,10,11.

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